

bq30z554EVM SBS 1.1 Impedance Track[™] Enabled Battery Management Solution EVM

The bq30z554EVM is a complete evaluation system for the bq30z554/bq29412 battery management solution. This system includes one bq30z554/bq29412 circuit module, a current sense resistor, two thermistors, and a link to Windows®-based PC software.

The circuit module includes one bq30z554 IC, one bq29412 IC, and all other onboard components necessary to monitor and predict capacity, perform cell balancing, monitor critical parameters, protect the cells from overcharge, overdischarge, short circuit, and overcurrent in 2-series, 3-series, or 4-series cell Lilon or Li-Polymer battery packs. The circuit module connects directly across the cells in a battery.

With the EV2300 or EV2400 interface board and software, users can read the bq30z554 data registers, program the chipset for different pack configurations, log cycling data for further evaluation, and evaluate the overall functionality of the bq30z554/bq29412 solution under different charge and discharge conditions.

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1 **Features**

- Complete evaluation system for the bg30z554 SBS 1.1-Compliant Advanced Gas Gauge with Impedance Track[™] technology, bq30z554 and bq29412 independent overvoltage protection integrated circuit (IC)
- Populated circuit module for quick setup
- Link to software that allows data logging for system analysis

1.1 Kit Contents

- bq30z554/bq29412 circuit module
- Links to support documentation ٠

1.2 **Ordering Information**

Table 1. Ordering Information

EVM PART NUMBER	CHEMISTRY	CONFIGURATION	CAPACITY
bq30z55EVM (PWR194)	Li-Ion	2-series, 3-series, or 4- series cell	Any

2 bg30z554 Device-Based Circuit Module

The bq30z554/bq29412-based circuit module is a complete and compact example solution of a bq30z554 circuit for battery management and protection of Li-Ion or Li-Polymer packs. The circuit module incorporates a bq30z554 battery monitor IC, bq29412 independent overvoltage protection IC, and all other components necessary to accurately predict the capacity of 2-series, 3-series, or 4-series cells.

2.1 **Circuit Module Connections**

Contacts on the circuit module provide the following connections:

- Direct connection to the cells: 1N (BAT-), 1P, 2P, 3P, 4P (BAT+) •
- To the serial communications port (SMBC, SMBD, VSS)
- The system load and charger connect across PACK+ and PACK-٠
- To the system present pin (SYS PRES)

2.2 Pin Descriptions

PIN NAME	DESCRIPTION
1N	-ve connection of first (bottom) cell
1P	+ve connection of first (bottom) cell
2P	+ve connection of second cell
3P	+ve connection of third cell
4P	+ve connection of fourth (top) cell
SMBC	Serial communication port clock
SMBD	Serial communication data port
VSS	Pack negative terminal
PACK-	Pack negative terminal
SYS PRES	System present pin (if low, system is present)
PACK+	Pack positive terminal

3 bq30z554 Circuit Module

This section contains information on configuration and fuse-blowing tests for the bq30z554/bq29412 implementation.

3.1 Choosing Particular Precharge Mode

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The bq30z554 contains an internal precharge FET; however, the default firmware configuration uses the Charge FET for precharge. To evaluate the internal precharge FET, change the least two significant bits in DF:Configuration:Charging Configuration to be 0,0. See the *bq30z5x-R1 Technical Reference Manual* (SLUU852) for additional information.

3.2 Testing Fuse-Blowing Circuit

To prevent the loss of board functionality during the fuse-blowing test, the actual chemical fuse is not provided in the circuit. FET Q1 drives TP8 low if a fuse-blow condition occurs; monitoring TP8 can be used to test this condition.

NOTE: Pull up TP8 to test the fuse circuit.

4 Circuit Module Physical Layouts, Schematic and Bill of Materials

This section contains the board layout, assembly drawings, schematic, and bill of materials for the bq30z554/bq29412 circuit module.

4.1 Board Layout

This section shows the dimensions, PCB layers, and assembly drawing for the bq30z554 module.









Figure 2. Top Assembly





Figure 3. Top Layer







Figure 5. Inner Layer 2









Figure 7. Bottom Assembly





Figure 8. Schematic



4.2 Bill of Materials

Table 2. Bill of Materials

Count	Reference Design	Value	Description	Size	Part Number	Manufacturer
18	C1-8 C11-17 C21 C24 C25	0.1uF	Capacitor, Ceramic, 50 V, X7R, 20%	0603	Std	Any
4	C9 C18-20	1.0uF	Capacitor, Ceramic, 25 V, X7R, 20%	0805	Std	Any
1	C10	0.22uF	Capacitor, Ceramic, 25 V, X7R, 20%	0603	Std	Any
2	C22 C23	0.1nF	Capacitor, Ceramic, 50 V, X7R, 20%	0603	Std	Any
2	D1 D3	1SS355	Diode, Switching, 90V, 225 mA lfm, High speed	SOD-323	1SS355TE-17	Rohm
l	D2	MM3Z5V6C	Diode, Zener, 5.6V, 200mw	SOD-323	MM3Z5V6C	Fairchild
)	F1		Fuse, Chemical, Thermal, xxA	SFDxxx		Sony
	J1	PTC36SAAN	Header, Male 2-pin, 100mil spacing, (36-pin strip)	0.100 inch x 2	PTC36SAAN	Sullins
	J2	22-05-3041	Header, Friction Lock Ass'y, 4-pin Right Angle,	0.400 x 0.500	22-05-3041	Molex
l	J3	PTC36SAAN	Header, Male 3-pin, 100mil spacing, (36-pin strip)	0.100 inch x 3	PTC36SAAN	Sullins
1	J4	56579-0519	Connector, USB, Mini AB 5-pins	0.354 X 0.307 Inches	56579-0519	Molex
9	R1-4 R11-12 R18 R26- 27	100	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
6	R5-9 R25	1K	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
	R10	.010 75ppm	Resistor, Chip, 0.010 Ohms, 1-W, xx%	2512	WSL2512R0100FEA	Vishay
2	R13 R32	50K	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
	R14	220K	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
3	R15 R17 R19	5.1K	Resistor, Chip, 1/16-W, 5%	0603	Std	Any
2	R16 R20	3M	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
2	R21 R33	10k	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
2	R22-23	200	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
2	R24 R30	10K	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
	R28	300	Resistor, Chip, 1W, 5%	2512	Std	Any
	R29	1M	Resistor, Chip, 1/16W, 5%	0603	Std	Any
	R31	0	Resistor, Chip, 1/16-W, 5%	0603	Std	Std
	SW1	EVQ-PLHA15	Switch, Push button, Momentary, 1P1T, 50-mA, 12-V	0.200 x 0.200 inch	EVQ-PLHA15	Panasonic
	TB1	ED1514	Terminal Block, 2-pin, 6-A, 3.5mm	0.27 x 0.25	ED555/2DS	OST
	TB2	ED1515	Terminal Block, 3-pin, 6-A, 3.5mm	0.41 x 0.25	ED555/3DS	OST
2	RT1-2	10K	Thermistor, 10K ohms	0.095 X 0.150	"CH25-3H103 or	
103AT- 2"	Semitec					
I	TP2	GND	Test Point, White, Thru Hole Color Keyed	0.100 x 0.100 inch	5002	Keystone
I	TP8	FUSE	Test Point, White, Thru Hole Color Keyed	0.100 x 0.100 inch	5002	Keystone
1	TP13	PGIO	Test Point, White, Thru Hole Color Keyed	0.100 x 0.100 inch	5002	Keystone
1	Q1	FDN339AN	MOSFET, N-ch, 20-V, 3A, 0.05-Ohms	SOT23	FDN339AN	Fairchild



Table 2. Bill of Materials (continued)

Count	Reference Design	Value	Description	Size	Part Number	Manufacturer
2	Q2-3	Si7114DN	MOSFET, Fast Switching, NChan, 30V, 18.3A, 7.5millohm	PWRPAK 1212	Si7114DN-T1-E3	Vishay
1	Q4	2N7002K	MOSFET, Nch, 60V, 300 mA, 2-Ohms	SOT23	2N7002K-T1-E3	Vishay
1	Q5	FDS4435BZ	MOSFET, Pch, -30V, -8.8A, 20-milliohm	SO8	FDS4435BZ	Fairchild
1	U1	BQ29412DCT	IC, Voltage Protection for 2, 3, 4 Cell Lion , 2nd Protection, 4.45 v OVP	SSOP-08	BQ29412DCT	ТІ
1	U2	BQ30Z554DBT	IC, 2-Series, 3-Series, and 4-Series Li-Ion Battery Pack Manager	TSSOP-38	BQ30Z554DBT	ТІ
1			PCB		PWR194	Std

4.3 bq30z554/bq29412 Circuit Module Performance Specification Summary

This section summarizes the performance specifications of the bq30z554/bq29412 circuit module.

Table 3. Performance Specification Summary

Specification	Min	Тур	Max	Units
Input voltage Pack+ to Pack-	5	15	25	V
Charge and discharge current	0	2	7	А

5 EVM Hardware and Software Setup

This section describes how to install the bq evaluation software, and how to connect the different components of the EVM.

5.1 System Requirements

The bq evaluation software (EVSW) requires Windows 2000, Windows XP, Windows Vista, or Windows 7.

5.2 Software Installation

NOTE: To get the latest software archive, contact the Texas Instruments field representative assigned to work with this device.

To install the EVSW, do the following:

- 1. Save the archive to a temporary directory.
- 2. Double-click on the executable filename, and follow the installer instructions to complete the EVSW installation.

If the EV2300 or EV2400 was not previously installed: After EVSW installation, a TI USB DRIVER INSTALLER pops up. Click **Yes** for the agreement message and follow its instructions.

3. Plug the EV2300 or EV2400 into a USB port.

6 Troubleshooting Unexpected Dialog Boxes

Users downloading the files must be logged in as the administrator, or must have privileges to install new programs.

The driver is not signed, so the administrator must allow installation of unsigned drivers in the operating system policy.

7 Hardware Connection

The bq30z554EVM-001 comprises two hardware components: the bq30z554/bq29412 circuit module and the EV2300 or EV2400 PC interface box.

7.1 Connecting the bq30z554/bq29412 Circuit Module to a Battery Pack

Figure 9 shows how to connect the bq30z554/bq29412 circuit module to the cells and system load/charger.

The cells must be connected in the following order:

- 1. 4-Cell Pack: 1N (BAT–), 1P, 2P, 3P, then 4P (see Section 2.2 for definitions)
- 2. 3-Cell Pack: 1N (BAT-), 1P, 2P, and then connect 4P and 3P together
- 3. 2-Cell Pack: 1N (BAT-), 1P, and then connect 4P, 3P, and 2P together

To start charge or discharge test, connect the SYS PRES pin to the Pack- pin to set SYS PRES state. To test sleep mode, disconnect the SYS PRES pin.





Figure 9. bq30z554 Circuit Module Connection to Cells and System Load/Charger

7.2 PC Interface Connection

To configure the hardware to interface to the PC, do the following:

1. Connect the bq30z554 device-based smart battery to the EV2300 or EV2400 using the provided cable or the connections shown in Table 4.

Table 4. Circuit Module to EV2300 or EV2400 Connections

bq30z554 Device-Based Battery	EV2300 or EV2400
SMBD	SMBD
SMBC	SMBC
VSS	GND

2. Connect the PC USB cable to the EV2300 or EV2400 and the PC USB port.

The bq30z554EVM-001 is now set up for operation.



8 Operation

This section details the operation of the EVSW.

NOTE: The EV2300 driver does not support Windows Sleep or Hibernate states. If communicating with the EV2300 or if the EVM presents a problem, unplug the USB cable and then plug it back in. If the problem continues, determine if the EVM is in Shutdown mode. The bq30z554 can be awakened by momentarily pressing SW1 if cell voltage is present.

8.1 Starting the Program

With the EV2300 or EV2400 and the bq30z554EVM connected to the computer, run the EVSW from the Desktop Icon or Start | All Programs | Texas Instruments | bq Evaluation Software menu sequence. The SBS Data screen appears. Data begins to appear once the Refresh (single time scan) button is clicked, or when the Keep Scanning checkbox is checked. To disable the scan feature, deselect Keep Scanning.

The continuous scanning period can be set via the **Options** and **Set Scan Interval** menu selections. The range for this interval is 0 ms to 65535 ms. Only items that are selected for scanning are scanned within this period.

The EVSW provides a logging function that logs the values that were last scanned by the EVSW. To enable this function, click the **Start Logging** button; this causes the **Keep Scanning** button to be selected. When logging is *Stopped*, the **Keep Scanning** button is still selected and has to be manually unchecked.

The logging interval is specified under the **Options** menu with the maximum value of 65535 ms. The **Log** interval cannot be smaller than the scan interval because this results in the same value being logged at least twice.



🐺 Texas Instrum	Nindow Help	AL WORLD S	IGNA	LP	RO	CESSING [™]	
Refresh Start S	stop <mark>√ K</mark> eep Write	2 word <u>G</u> raphs					
Name	Value Unit Log Scan	Name	Value U	nit Log	Scan	Name	Value Unit Log Scan
Manufacturer Access	0000 hex 🔽 🔽	Temperature		QC 🔽	7	Full charge Capacity	3897 mAh 🔽 🔽
Remaining Cap. Alarm	300 mAh 🔽 🔽	Voltage		v 🔽		Run time To Empty	19887 min 🔽 🔽
Remaining Time Alarm	10 min 🔽 🔽	Current	-9 m	A 🔽		Average Time to Empty	19887 min 🔽 🔽
Battery Mode	6081 hex 🔽 🔽	Average Current	-9 m	A 🔽		Average Time to Full	65535 min 🔽 🔽
At Rate	0 mA 🔽 🗹	Max Error	100 9	% 🔽		Charging Current	0 mA 🔽 🔽
At Rate Time To Full	65535 min 🔽 🔽	Relative State of Charge	77 9	% 🔽	-	Charging Voltage	0 mV 🔽 🔽
At Rate Time To Empty	65535 min 🔽 🔽	Absolute State of Charge	68 9	% 🔽	V	Battery Status	48C0 hex 🔽 🔽
At Rate OK	1 - 🔽 🔽	Remaining Capacity	2983 m.	Ah 🔽		Cycle Count	0 - 🔽
	SBS	Y IT	Status			Permanent	Failure/Safety
Cell Voltage 4 Battery Voltage Pack Voltage	0 mV V 11936 mV V 109 mV V 27894 cWh V	RSVD RSVD RSVD RSVD	GAUGE C	(Hex)	000	JSE Cell Temp CHG Bit 0 FET Temp D210 CT	28.4 degC 🔽 28.7 degC 🔽
Max Power : Version: 1.0.3 bq30z554ExtSBS	Bit 31 RSVD RSVD OFF SLEEP XCHG XDSG	XL SLPCC LPQMA MBLCA IN	IN RT S	HV STL eration SDV C	AV I T U Status	LV лт Віко ((Hex) 00006100 Вік 15 АМО АЛТН БНІРМ БОК	
Version: 1.0.3	RSVD RSVD OFF SLEEP XCHG XDSG INING D OTA TDA RSVD 0	PV OT HT STH		HV STL Pration SDV C CB FI	AV I T U Status	LV лт Віко ((Hex) 00006100 Вік 15 АМО АЛТН БНІРМ БОК	4 S Bit O

Figure 10. SBS Data Screen

This screen shows the SBS data set along with additional ManufacturersAccess() command information, such as individual cell measurements. Additional Flag and Static data can be viewed by selecting the appropriate tab at the bottom of the SBS screen.

Data such as SBS.ManufacturerName() is static and does not change. This data is viewed separately using the **Static Data** tab at the bottom of the screen.

Dragging the splitter bar (the line that separates the Flags/Static data from SBS values) changes the height of the **Flags/Status Bits** display. Selecting **View** then **Auto Arrange** returns the splitter bar to its original location.

8.2 Setting Programmable bq30z554 Options

The bq30z554 data flash comes configured per the default settings detailed in the *bq30z554 SBS 1.1-Compliant Gas Gauge With Impedance Track*TM Datasheet (SLUSB29A). Ensure that the settings are correctly changed to match the pack and application for the bq30z554 solution being evaluated.

IMPORTANT: To get the best performance, it is essential to correctly set these options.

Use the **Data Flash** screen to configure the settings.

Operation

IEXAS INS	STRUMENTS	RΕ	AL WORLD S	IGNA	L PRO	CESSING [™]		
<u>R</u> ead All	Write All Write	e All, <u>P</u> reserve	*Right click on constant nam	ne for more info	mation	All View		_
	Power	Advanced	I Charge Algorithm	Calibration				
Pe	rmanent Fail	PF	Status	Black Box	1 I	Lifetimes		Settings
Gas	Gauging 1	Ra T	able 🍸 S,	ystem Data	Ĭ	SBS Configuration		Protections
Name	Value	Unit	Name	Value	Unit	Name	Value	Unit
State	-	-	Max Avg I Last Run	-2000	mA	Reserve Cap-mAh	0	mAh
Qmax Cell 0	4400	mAh	Max Avg P Last Run	-3022	cW	Reserve Cap-cWh	0	cWh
Qmax Cell 1	4400	mAh	IT Cfg	-	-	Remcap Smoothing Filter	250	-
Qmax Cell 2	4400	mAh	Load Select	7	-	Fast Scale Start SOC	10	%
Qmax Cell 3	4400	mAh	Load Mode	0	-	Turbo Cfg	-	-
Qmax Pack	4400	mAh	Ra Filter	50.0	%	Min Turbo Power	0	cW
Update Status	04	-	Ra Max Delta	15	%	Pack Resistance	30	mOhms
Cell O Chg Volta	age at EoC 4200	mV	Design Resistance	42	mOhms	System Resistance	0	mOhms
Cell 1 Chg Volta	ge at EoC 4200	mV	Reference Grid	4	-	High Frequency Resistance	20	mOhms
Cell 2 Chg Volte	age at EoC 4200	mV	Resistance Parameter Filter	65142	-	Reserve Energy %	2	%
Cell 3 Chg Volto	age at EoC 4200	mV	Term Voltage	9000	mV	Current Thresholds	-	-
Current at EoC	250	mA	Term Voltage Delta	300	mV	Dsg Current Threshold	100	mA
te Avg I Last Run	-2000	mA	User Rate-mA	0	mA	Chg Current Threshold	50	mA
Avg P Last Run	-3022	cW	User Rate-cW	0	cW	Quit Current	10	mA

Figure 11. Data Flash Screen, First-Level Safety Class

To read all of the data from the bq30z554 data flash, click on menu option | Data Flash | Read All |.

To write to a data flash location, click on the desired location, enter the data, and click **Enter**, which writes the entire tab of flash data, or select menu option | **Data Flash** | **Write All** |. The data flash must be read before any writes are performed to avoid any incorrect data being written to the device.

The | File | Special Export | menu options allows the data flash to be exported.

The data flash configuration can be saved to a file by selecting | **File** | **Export** | and entering a file name. In this way, a data flash file also can be retrieved, imported, and written to the bq30z554 using the **Write All** button. The configuration information of the bq30z554 data is held in the data flash.

The bq30z554 allows for an automatic data flash export function, similar to the **SBS Data logging** function. This feature, when selected via | **Options** | **Auto Export** |, exports data flash to a sequential series of files named as *FilenameNNNN.gg*, where N = a decimal number from 0 to 9.

The *AutoExport* interval is set under the | **Options** | menu with a minimum value of 15 seconds. The **AutoExport** filename is set under the | **Options** | menu.

When a check is next to | **AutoExport** |, *AutoExport* is in progress. The same menu selection is used to turn *AutoExport* on and off.



If the data flash screen is blank, then the bq30z554 in use may not be supported by the EVSW version in use. An upgrade may be required.

9 Calibration Screen

9.1 How to Calibrate

The bq30z554 must be calibrated using power supplies, or a power supply and cell simulation resistors (300 Ω or less) before cells are attached. Before the bq30z554 is calibrated, do the following:

- Connect and measure a 2-A current source from 1N (–) and Pack (–) to calibrate without using the FETs (calibration using the FETs is not recommended).
- Measure each cell voltage.
- Measure the temperature of the pack.
- Whether the foregoing steps are necessary depends on the type of calibration being performed.

9.2 Calibrate the bq30z554

To calibrate the bq30z554, do the following:

- Select the types of calibration to be performed.
- Enter the measured values for the types selected (except for CC Offset Calibration).
- If **Temperature Calibration** is selected, select the sensor that is to be calibrated.
- Click the appropriate button to initiate the desired calibration.

9.3 Board Offset Calibration

This performs the offset calibration for the current offset of the board.

- Remove any current source, load, or external voltage from the PACK terminals.
- Click the Calibrate Board Offset button.

9.4 Pack Voltage Calibration

This calibrates the voltage at the AFE Pack pin.

- Ensure that **Voltage Calibration** has been performed for the pack. If **Voltage Calibration** is not performed, then **Pack Calibration** calibrates incorrectly.
- · Remove load and external voltage applied between Pack+ and Pack-.
- Click the Calibration Pack Voltage button to calibrate.

Calibration Screen

🜵 Texas İnst	RUMENTS	REAL	WORLD	SIGNAL PRO	CESSING [™]	
Volta	age and Tempera	ture 📋		Current	Check for continuou	is updates.
Please ensure that scanning/communication is off on all other open windo Voltage and Temperature Calibration					Current Values	
Calibrate Voltage and Temperature as indicated below		Voltage: Enter actual cell voltages using stack ground as reference. Cells configured for use are active. Check voltage calibration checkbox.		Parameter	Value	
		Temperature: Enter actual sensor temperatures. Check to include in calibration. Click Voltage/Temperature calibration button to calibrate.			n. Cell Voltage 1	3998
		Click Voltage/Tempera	ature calibration button	to calibrate.	Cell Voltage 2	3924
1					Cell Voltage 3	3998
	Measured	Enter actual	Cell		Cell Voltage 4	0
	voltage	voltage	Cou	nt	Battery Voltage	11936
- Voltage	3998	Gall 4000 mil	3	-	Pack Voltage	110
Calibration	mv	Cell 1 M mV	3		Temperatures Internal Temp	20.0
21	7922 mV	Cell 1 + 2 8000 mV	Ensure volta	ge reference is stable. Calibratior	with TC1 Tomp	20.0
	11000		cells connec	ted is not recommended unless of	ells Ton T	28.6
	mv Le	#1+2+3 12000 mV		of rest. If using resistors simulati	Cell Temp	28.6
	11920 mV Cell1	+2+3+4 ¹⁶⁰⁰⁰ mV		esistance must be less than 300 gured number of cells in Dataflas		28.9
	Measured temperature	Enter actual temperature			Raw Calibration Dataflash Value:	
🔽 Internal Ter	mp 20.0 캜	2	н		Parameter	Value
			χ.		Cell Scale 0	20451
🔽 Ext 1 Temp	28.6 캜	2	6		Cell Scale 1	20468
Extremp			A		Cell Scale 2	20520
🔲 Ext 2 Temp	28.8 캜	킬	Ħ.		Cell Scale 3 Pack Gain	20517 49000
- Ence romp					Battery Gain	49000
- Pack Calibratio					CC Gain	0.942
		/leasured Enter a	actual		Capacity Gain	280932.625
	v v	oltage voltag			Current Offset	-7204
Calibrate Pa	ck	110 mV 12000		Continue	CC Offset Samples	64
Voltage		12000		calibrations on	Board Offset	0
				second page	Int Temp Offset	0
					Ext 1 Temp Offset	0
					Ext 2 Temp Offset	0
				Version: 0.1.0.6 bq8050 Ho	stcal	

Figure 12. Calibration Screen



10 Pro (Advanced) Screen

10.1 SMB Communication

The set of read or write operations over SMBus are not specific to any gas gauge. These are provided as general-purpose communication tools.

10.2 Hex/Decimal Converter

The **Hexadecimal Value** and **Decimal Value** boxes convert between hexadecimal (hex) and decimal as soon as values are typed into the boxes. Invalid values can cause erroneous results.

When scaling converted hex values to a higher number of bytes, follow these rules:

- When **Unsigned** is selected, the left pad contains zeroes.
- When **Signed** is selected, the left pad contains zeroes for a positive number, or the left pad contains *F* for negative numbers.

10.3 Reprogramming

To reprogram the device, do the following:

- Ensure that the gauge is in Full Access mode. To do this, use the **Seal/Authentication** screen (see Section 11).
- Use the Write SMB Word feature to put the gauge into ROM mode (0x0033 to cmd 0x00).
- Use the **Srec** programming feature to browse for the desired .srec or .senc file, then click the **Program** button to start the transfer.
- Use the SMB Command feature to send 0x08 to execute the program.

If the firmware version was updated, close and re-launch the EVSW to synchronize the tool with the new firmware.

Pro (Advanced) Screen

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	ients bq Gas Gauge Evaluation Software - bq30z554 v0.01 - [Pro (Advanced) Screen] ns Flash Memory Window Help	X
	TEXAS INSTRUMENTS REAL WORLD SIGNAL PROCESSING [™]	
	This screen is only for advanced users. Some commands may cause permanent damage to the hardware. Please use caution. All Values are in Hexadecimal without the 0x prefix. Target Address 17 Send SMB Command	
	SMB Command Send	
SB5	Read SMB Word SMB Command 00 Bead Result (hex) None.	
	Write SMB Word	
Data Flash	SMB Command 00 Word (hex) 0033 Write	
- Tush	Read SMB Block	
Pro	SMB Command 78 Result (hex) None.	
	Write SMB Block	
Calibrate	Wite SMB Block Block Data 0102 0304 05 06	
	Hexadecimal to Decimal converter and vice versa	
Seal Auth	Hexadecimal value $\boxed{00} = \frac{\text{Signed}}{\text{UnSigned}} \stackrel{\circ}{\leftarrow} \text{Decimal value } \boxed{00}$	
	Srec programming V Safe Erase	
bgCHEM	C:\Users\a0967786\Desktop\bg30z554\Firmware\BR_B(Program	
раснем		
100%		
Fuel Gauge 77%		
Communication OK	SBS Task Progress: 100% Task Complete	ed. 03:40:29 PM

Figure 13. Pro (Advanced) Screen



11 Seal/Authentication Screen

To seal, unseal, or allow full access—which enables users to reprogram the device—select one of these three modes on the **Seal/Authentication** screen and click **Go**.

NOTE: When the device is sealed, users cannot write to the data flash.

The text boxes at the top of the screen are informational and their content loads during the unseal process.

Unsealing the bq30z554 is the reverse procedure from SHA-1 authentication. (For more information on SHA-1 encryption, refer to the *bq30z5x-R1 Technical Reference Manual* (SLUU852). The gas gauge generates the random number and challenges the EVSW, which must provide a valid key in order to unseal the device. Full access to ROM mode occurs in a similar manner. The **Seal/Authentication** screen shows the default 128-bit key in the **Key (129 bits)** text box.

	nents bq Gas Gauge Evaluation Software	- bq30z554 v0.01 - [Aut	n]			
🛱 File Wind		REAL	Woole Ci	GNAL PROCES	0. L.N. 0 TM	- 8 ×
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	Seal/UnSeal/Full Acces	s	Authentication		де Кеу	
		Seal/Ur	seal/Full Acces	S All displayed data is most digit first.	significant	
SB5	Key (128 bits)	Random Number from device	Random Number Key	+ Digest		
	0123456789ABCDEF FEDCBA9876543210			_	-	
Data						
Flash						
	Select mode	Current D	evice Mode			
Pro	C Seal	Full	Access			
	Unseal					
Calibrate	C Full Access					
Seal Auth	Go					
bqCHEM						
0% Fuel Gauge 77%						
Communication Of	κ.				SBS Task Progress: 100% Task Complet	ed. 03:41:28 PM

Figure 14. Seal/Authentication Screen

12 bqChem

bqChem enables users to access the library of previously characterized Li-Ion cell chemistries, and program the chemical database into the gauge. Users can sort by chemical ID or by cell manufacturer. For help to identify the chemistry for the cells, contact the Texas Instruments field representative assigned to work with this device.



Figure 15. bqChem Screen

The DFI section enables a user to read and write DFI and ROM files. These are complete binary images of the fuel gauge data flash. Once a golden pack is created, the data flash image can be used to quickly program other packs for mass production. The ROM file contains the same data as the DFI file, but adds an additional header for use by the *bqMTester production* tool. These files differ from the .gg files that a user can read and write in the **Data Flash** screen. The .gg files are simply text dictionaries that contain public configuration data. The DFI and ROM files are binary images that contain public, private, and proprietary information necessary for mass production.



Related Documentation from Texas Instruments

13 Related Documentation from Texas Instruments

For related documentation, contact the Texas Instruments field representative assigned to work with this device.

Documents:	Literature Number:
bq30z554 SBS 1.1-Compliant Gas Gauge With Impedance Track™ Datasheet	SLUSB29A
bq30z5x-R1 Technical Reference Manual	<u>SLUU852</u>
EV2300 EVM Interface Board User's Guide	SLUU159A
EV2400 EVM Interface Board User's Guide	<u>SLUU446</u>

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User Power/Frequency Use Obligations: This radio is intended for development/professional use only in legally allocated frequency and power limits. Any use of radio frequencies and/or power availability of this EVM and its development application(s) must comply with local laws governing radio spectrum allocation and power limits for this evaluation module. It is the user's sole responsibility to only operate this radio in legally acceptable frequency space and within legally mandated power limitations. Any exceptions to this are strictly prohibited and unauthorized by Texas Instruments unless user has obtained appropriate experimental/development licenses from local regulatory authorities, which is responsibility of user including its acceptable authorization.

For EVMs annotated as FCC – FEDERAL COMMUNICATIONS COMMISSION Part 15 Compliant

Caution

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Changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

FCC Interference Statement for Class A EVM devices

This equipment has been tested and found to comply with the limits for a Class A digital device, pursuant to part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference when the equipment is operated in a commercial environment. This equipment generates, uses, and can radiate radio frequency energy and, if not installed and used in accordance with the instruction manual, may cause harmful interference to radio communications. Operation of this equipment in a residential area is likely to cause harmful interference in which case the user will be required to correct the interference at his own expense.

FCC Interference Statement for Class B EVM devices

This equipment has been tested and found to comply with the limits for a Class B digital device, pursuant to part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference in a residential installation. This equipment generates, uses and can radiate radio frequency energy and, if not installed and used in accordance with the instructions, may cause harmful interference to radio communications. However, there is no guarantee that interference will not occur in a particular installation. If this equipment does cause harmful interference to radio or television reception, which can be determined by turning the equipment off and on, the user is encouraged to try to correct the interference by one or more of the following measures:

- Reorient or relocate the receiving antenna.
- Increase the separation between the equipment and receiver.
- · Connect the equipment into an outlet on a circuit different from that to which the receiver is connected.
- Consult the dealer or an experienced radio/TV technician for help.

For EVMs annotated as IC – INDUSTRY CANADA Compliant

This Class A or B digital apparatus complies with Canadian ICES-003.

Changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

Concerning EVMs including radio transmitters

This device complies with Industry Canada licence-exempt RSS standard(s). Operation is subject to the following two conditions: (1) this device may not cause interference, and (2) this device must accept any interference, including interference that may cause undesired operation of the device.

Concerning EVMs including detachable antennas

Under Industry Canada regulations, this radio transmitter may only operate using an antenna of a type and maximum (or lesser) gain approved for the transmitter by Industry Canada. To reduce potential radio interference to other users, the antenna type and its gain should be so chosen that the equivalent isotropically radiated power (e.i.r.p.) is not more than that necessary for successful communication.

This radio transmitter has been approved by Industry Canada to operate with the antenna types listed in the user guide with the maximum permissible gain and required antenna impedance for each antenna type indicated. Antenna types not included in this list, having a gain greater than the maximum gain indicated for that type, are strictly prohibited for use with this device.

Cet appareil numérique de la classe A ou B est conforme à la norme NMB-003 du Canada.

Les changements ou les modifications pas expressément approuvés par la partie responsable de la conformité ont pu vider l'autorité de l'utilisateur pour actionner l'équipement.

Concernant les EVMs avec appareils radio

Le présent appareil est conforme aux CNR d'Industrie Canada applicables aux appareils radio exempts de licence. L'exploitation est autorisée aux deux conditions suivantes : (1) l'appareil ne doit pas produire de brouillage, et (2) l'utilisateur de l'appareil doit accepter tout brouillage radioélectrique subi, même si le brouillage est susceptible d'en compromettre le fonctionnement.

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Conformément à la réglementation d'Industrie Canada, le présent émetteur radio peut fonctionner avec une antenne d'un type et d'un gain maximal (ou inférieur) approuvé pour l'émetteur par Industrie Canada. Dans le but de réduire les risques de brouillage radioélectrique à l'intention des autres utilisateurs, il faut choisir le type d'antenne et son gain de sorte que la puissance isotrope rayonnée équivalente (p.i.r.e.) ne dépasse pas l'intensité nécessaire à l'établissement d'une communication satisfaisante.

Le présent émetteur radio a été approuvé par Industrie Canada pour fonctionner avec les types d'antenne énumérés dans le manuel d'usage et ayant un gain admissible maximal et l'impédance requise pour chaque type d'antenne. Les types d'antenne non inclus dans cette liste, ou dont le gain est supérieur au gain maximal indiqué, sont strictement interdits pour l'exploitation de l'émetteur.

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This development kit is NOT certified as Confirming to Technical Regulations of Radio Law of Japan

If you use this product in Japan, you are required by Radio Law of Japan to follow the instructions below with respect to this product:

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- 2. Use this product only after you obtained the license of Test Radio Station as provided in Radio Law of Japan with respect to this product, or
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